TOSHIBA 2SK2035

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

2 S K 2 0 3 5

HIGH SPEED SWITCHING APPLICATIONS.

ANALOG SWITCHING APPLICATIONS.

High Input Impedance.

Low Gate Threshold Voltage: $V_{th} = 0.5 \sim 1.5 V$

Excellent Switching Times : $t_{on} = 0.16 \mu s$ (typ.)

 $t_{off} = 0.15 \mu s$ (typ.)

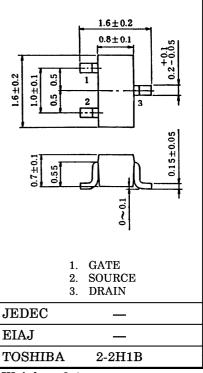
Small Package

Enhancement-Mode

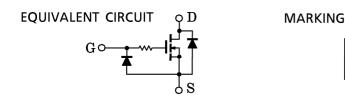
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	$v_{ m DS}$	20	V
Gate-Source Voltage	$v_{ m GSS}$	10	V
Drain Current	$_{ m I_D}$	100	mA
Drain Power Dissipation	$P_{\mathbf{D}}$	100	mW
Channel Temperature	${ m T_{ch}}$	150	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	°C

Unit in mm



Weight: 2.4mg



This transistor is electrostatic sensitive device. Please handle with caushon.

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACT	ERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{ m GSS}$	$V_{GS}=10V, V_{DS}=0$	_	_	1	μ A
Drain-Source Breakdown Voltage V		V _(BR) DSS	$I_{D} = 100 \mu A, V_{GS} = 0$	20		_	V
Drain Cut-off Cu	rrent	$I_{ m DSS}$	$V_{DS}=20V, V_{GS}=0$			1	μ A
Gate Threshold V	⁷ oltage	$ m v_{th}$	$V_{DS}=3V$, $I_{D}=0.1mA$	0.5		1.5	V
Forward Transfer	Admittance	$ Y_{fs} $	$V_{ m DS}$ =3V, $I_{ m D}$ =10mA	25	50		mS
Drain-Source ON	Resistance	R _{DS} (ON)	$I_D=10$ mA, $V_{GS}=2.5$ V		8	12	Ω
Input Capacitance	e	$\mathrm{c}_{\mathrm{iss}}$	V_{DS} =3V, V_{GS} =0, f=1MHz		8.5	_	рF
Reverse Transfer	Capacitance	$\mathrm{C}_{ extbf{rss}}$	$V_{DS}=3V$, $V_{GS}=0$, $f=1MHz$		3.3	_	pF
Output Capacitan	ice	C_{oss}	$V_{DS}=3V$, $V_{GS}=0$, $f=1MHz$	_	9.3	_	pF
Switching Time	Turn-on Time	t _{on}	V _{DD} =3V, I _D =10mA, V _{GS} =0~2.5V	1	0.16	_	μs
	Turn-off Time	t _{off}	V_{DD} =3V, I_{D} =10mA, V_{GS} =0~2.5V	_	0.15	_	μs

SWITCHING TIME TEST CIRCUIT

